

January 2000 Revised December 2000

GTLP17T616 17-Bit LVTTL/GTLP Bus Transceiver with Buffered Clock

General Description

The GTLP17T616 is a 17-bit registered bus transceiver that provides LVTTL to GTLP signal level translation. It allows for transparent, latched and clocked modes of data flow and provides a buffered GTLP (CLKOUT) clock output from the LVTTL CLKAB. The device provides a high speed interface between cards operating at LVTTL logic levels and a backplane operating at GTLP logic levels. High speed backplane operation is a direct result of GTLP's reduced output swing (<1V), reduced input threshold levels and output edge rate control. The edge rate control minimizes bus settling time. GTLP is a Fairchild Semiconductor derivative of the Gunning Transistor logic (GTL) JEDEC standard JESD8-3.

Fairchild's GTLP has internal edge-rate control and is Process, Voltage, and Temperature (PVT) compensated. Its function is similar to BTL or GTL but with different output levels and receiver thresholds. GTLP output LOW level is typically less than 0.5V, the output level HIGH is 1.5V and the receiver threshold is 1.0V.

Features

- Bidirectional interface between GTLP and LVTTL logic levels
- Designed with edge rate control circuitry to reduce output noise on the GTLP port
- V_{REF} pin provides external supply reference voltage for receiver threshold adjustibility
- Special PVT compensation circuitry to provide consistent performance over variations of process, supply voltage and temperature
- TTL compatible driver and control inputs
- \blacksquare Designed using Fairchild advanced BiCMOS technology
- Bushold data inputs on A port to eliminate the need for external pull-up resistors for unused inputs
- Power up/down and power off high impedance for live insertion
- Open drain on GTLP to support wired-or connection
- Flow through pinout optimizes PCB layout
- D-type flip-flop, latch and transparent data paths
- A Port source/sink -24mA/+24mA
- B Port sink +50mA
- GTLP buffered CLKAB signal available (CLKOUT)

Ordering Code:

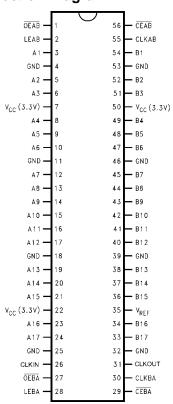
Order Number	Package Number	Package Description
GTLP17T616MEA	MS56A	56-Lead Shrink Small Outline Package (SSOP), JEDEC MO-118, 0.300 Wide
GTLP17T616MTD	MTD56	56-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 6.1mm Wide

Device also available in Tape and Reel. Specify by appending suffix letter "X" to the ordering code.

Pin Descriptions

Connection Diagram

Pin Names	Description
OEAB	A-to-B Output Enable (Active LOW) (LVTTL levels)
OEBA	B-to-A Output Enable (Active LOW) (LVTTL levels)
CEAB	A-to-B Clock/LE Enable (Active LOW) (LVTTL levels)
CEBA	B-to-A Clock/LE Enable (Active LOW) (LVTTL levels)
LEAB	A-to-B Latch Enable (Transparent HIGH) (LVTTL levels)
LEBA	B-to-A Latch Enable (Transparent HIGH) (LVTTL levels)
V _{REF}	GTLP Input Threshold Reference Voltage
CLKAB	A-to-B Clock (LVTTL levels)
CLKBA	B-to-A Clock (LVTTL levels)
A1-A17	A-to-B Data Inputs or B-to-A 3-STATE Outputs
B1-B17	B-to-A Data Inputs or A-to-B Open Drain Outputs (GTLP Levels)
CLKIN	B-to-A Buffered Clock Output (LVTTL levels)
CLKOUT	GTLP Buffered Clock Input/Output of CLKAB (GTLP Levels)



Truth Table (Note 1)

		Output	Mode			
CEAB	OEAB	LEAB	CLKAB	Α	В	
Х	Н	Х	Х	Х	Z	Latched
L	L	L	Н	Х	B ₀ (Note 2)	storage
L	L	L	L	Х	B ₀ (Note 3)	of A data
Х	L	Н	Х	L	L	Transparent
Х	L	Н	Х	Н	Н	
L	L	L	1	L	L	Clocked
L	L	L	\uparrow	Н	Н	storage
						of A data
Н	L	L	Х	Х	B ₀ (Note 3)	Clock inhibit

 $\textbf{Note 1:} \ A\text{-to-B data flow is shown. B-to-A data flow is similar but uses } \overline{\mathsf{OEBA}}, \ \mathsf{LEBA}, \ \mathsf{CLKBA}, \ \mathsf{and} \ \overline{\mathsf{CEBA}}.$

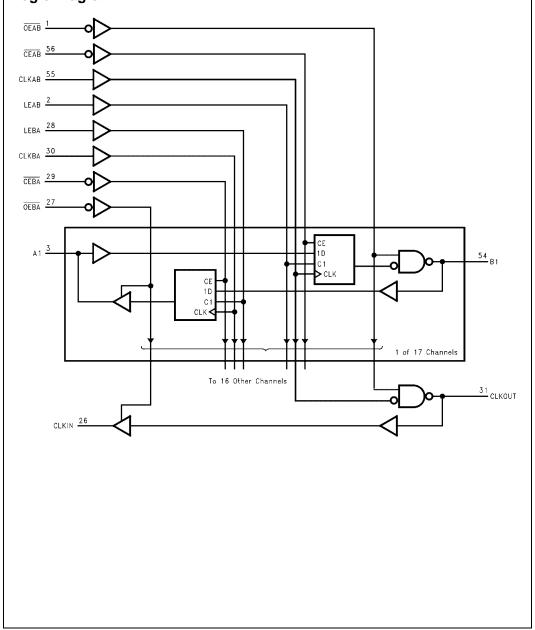
Note 2: Output level before the indicated steady state input conditions were established, provided that CLKAB was HIGH before LEAB went LOW.

 $\textbf{Note 3:} \ \ \textbf{Output level before the indicated steady-state input conditions were established.}$

Functional Description

The GTLP17T616 is a 17 bit registered transceiver containing D-type flip-flop, latch and transparent modes of operation for the data path and a GTLP translation of the CLKAB signal (CLKOUT). Data flow in each direction is controlled by the clock enables (CEAB and CEBA), latch enables (LEAB and LEBA), clock (CLKAB and CLKBA) and output enables (OEAB and OEBA). The clock enables (CEAB and CEBA) enable all 17 bits. The output enables (OEAB and OEBA) control the 17 bits of data and the CLKOUT/CLKIN buffered clock path. For A-to-B data flow, when CEAB is low, the device operates on the LOW-to-HIGH transition of CLKAB for the flip-flop and on the HIGH-to-LOW transition of LEAB for the latch path. That is, if CEAB is LOW and LEAB is LOW the A data is latched regardless as to the state of CLKAB (HIGH or LOW) and if LEAB is HIGH the device is in transparent mode. When OEAB is LOW the outputs are active. When OEAB is HIGH the outputs are high impedance. The data flow of B-to-A is similar except that CEAB, OEBA, LEBA and CLKBA are used.

Logic Diagram



Absolute Maximum Ratings(Note 4)

Recommended Operating Conditions

-0.5V to +4.6V Supply Voltage (V_{CC}) -0.5V to +4.6V DC Input Voltage (V_I)

DC Output Voltage (V_O)

Outputs 3-STATE -0.5V to +4.6VOutputs Active (Note 5) -0.5V to +4.6V

DC Output Sink Current into

A Port I_{OL} 48 mA

DC Output Source Current from

A Port I_{OH}

DC Output Sink Current into

B Port in the LOW State, I_{OL} DC Input Diode Current (I_{IK})

 $V_I < 0V$ -50 mA

DC Output Diode Current (I_{OK})

 $V_O < 0V$ -50 mA **ESD** Rating >2000V -65°C to +150°C

Storage Temperature (T_{STG})

Supply Voltage V_{CC}/V_{CCQ} 3.15V to 3.45V

Bus Termination Voltage (V_{TT})

GTLP 1.47V to 1.53V 0.98V to 1.02V V_{REF}

Input Voltage (V_I)

-48 mA

100 mA

on A Port and Control Pins 0.0V to $V_{\mbox{\footnotesize CC}}$ 0.0V to V_{CC}

HIGH Level Output Current (I_{OH})

A Port

LOW Level Output Current (I_{OL})

A Port +24 mA B Port +50 mA

-24 mA

Operating Temperature (T_A) -40°C to +85°C

Note 4: Absolute Maximum continuous ratings are those values beyond which damage to the device may occur. Exposure to these conditions or conditions beyond those indicated may adversely affect device reliability. Functional operation under absolute maximum rated conditions in not

Note 5: I_O Absolute Maximum Rating must be observed.

DC Electrical Characteristics

Over Recommended Operating Free-Air Temperature Range, $V_{REF} = 1.0V$ (unless otherwise noted).

Symbol		Test Conditions		Min	Typ (Note 6)	Max	Units
V _{IH}	B Port					V _{TT}	V
	Others	1		2.0			V
V _{IL}	B Port			0.0		V _{REF} - 0.05	V
	Others	1				0.8	V
V _{REF}	B Port	$V_{TT} > V_{REF} + 50 \text{ mV}$		0.25	1.0	V _{CC} – 1.2V	V
V _{TT}	B Port	$V_{TT} > V_{REF} + 50 \text{ mV}$		V _{REF} + 50 mV	1.5	V _{CC}	
V _{IK}		V _{CC} = 3.15V	I _I = -18 mA			-1.2	V
V _{OH}	A Port	V _{CC} = Min to Max (Note 7)	$I_{OH} = -100 \mu A$	V _{CC} -0.2			
		V _{CC} = 3.15V	$I_{OH} = -18 \text{ mA}$	2.4			V
			I _{OH} = -24mA	2.2			
V _{OL}	A Port	V _{CC} = Min to Max (Note 7)	$I_{OL} = 100 \mu A$			0.2	V
		V _{CC} = 3.15V	I _{OL} = 24mA			0.5	V
	B Port	V _{CC} = 3.15V	I _{OL} = 40 mA			0.4	V
			I _{OL} = 50 mA			0.55	V
l _l	Control Pins	V _{CC} = Min to Max (Note 7)	V _I = 3.45V or 0V			±5	μΑ
	A Port	V _{CC} = 3.45V	V _I = 3.45V or 0V			±10	μΑ
	B Port	V _{CC} = 3.45V	V _I = 0 to 3.45V			±5	μΑ
I _{PU/PD}	All Ports	V _{CC} = 0 to 1.5V	$V_I/V_O = 0 \text{ to } 3.45V$			±30	μΑ
l _{OFF}	All Ports	V _{CC} = 0	V_{I} or $V_{O} = 0$ to 3.45V			30	μΑ
I _{I(hold)}	A Port	V _{CC} = 3.15V	$V_{I} = 0.8V$	75			^
			V _I = 2.0V			-75	μΑ
l _{ozh}	A Port	V _{CC} = 3.45V	V _O = 3.45V			10	A
	B Port	1	V _O = 1.5V			5	μΑ
l _{OZL}	A Port	V _{CC} = 3.45V	$V_0 = 0V$			-10	A
	B Port		V _O = 0.55V			-5	μΑ
I _{CC}	A or B Ports	V _{CC} = 3.45V	Outputs HIGH			45	
(V _{CC} /V _{CCQ})		$I_O = 0$	Outputs LOW			45	mA
		V _I = V _{CC} or GND	Outputs Disabled			45	
ΔI _{CC} (Note 8)	A Port and Control Pins	$V_{CC} = 3.45V$, A or Control Inputs at V_{CC} or GND	One Input at 2.7V		0	2	mA

DC Electrical Characteristics (Continued)

;	Symbol Test Conditions		Min	Typ (Note 6)	Max	Units
C _i	Control Pins	$V_I = V_{CC}$ or 0			5.0	
	A Port	$V_I = V_{CC}$ or 0			7.0	pF
	B Port	$V_I = V_{CC}$ or 0			9.0	

Note 6: All typical values are at V $_{CC}$ = 3.3V, V $_{CCQ}$ = 3.3V, and T $_{A}$ = 25 $^{\circ}C.$

Note 7: For conditions shown as Min or Max, use the appropriate value specified under recommended operating conditions.

Note 8: This is the increase in supply current for each input that is at the specified TTL voltage level rather than V_{CC} or GND.

AC Operating Requirements

Over recommended ranges of supply voltage and operating free-air temperature, $V_{REF} = 1.0V$ (unless otherwise noted).

Symbol		Test Conditions	Min	Max	Unit	
f _{TOGGLE}	Maximum Toggle Frequency	Transparent Mode	125		MHz	
f _{MAX}	Maximum Clock Frequency	Registered Mode	125		IVITZ	
t _{WIDTH}	Pulse Duration	LEAB or LEBA HIGH	3.0		ns	
		CLKAB or CLKBA HIGH or LOW	3.0		115	
t _{SU}	Setup Time	A before CLKAB↑	0.6			
		B before CLKBA↑	1.2			
		A before LEAB↑	0.5		ns	
		B before LEBA↑	1.3			
		CEAB before CLKAB↑	1.4			
		CEBA before CLKBA↑	1.2			
t _{HOLD}	Hold Time	A after CLKAB↑	0			
		B after CLKBA↑	0.2			
		A after LEAB↑	0.2			
		B after LEBA↑	0		ns	
		CEAB after CLKAB↑	0.5			
		CEBA after CLKBA↑	0.6			

AC Electrical Characteristics

Over recommended range of supply voltage and operating free-air temperature, V_{REF} = 1.0V (unless otherwise noted). C_L = 30 pF for B Port and C_L = 50 pF for A Port.

Symbol	From	То	Min	Тур	Max	Unit	
Symbol	(Input)	(Output)		(Note 9)			
PLH	A	В	1.6	4.0	6.3	ns	
PHL			1.0	2.5	4.4	113	
t _{PLH}	LEAB	В	1.5	3.9	6.3	ns	
PHL			0.9	2.3	4.2	113	
PLH	CLKAB	В	1.6	4.0	6.3	20	
PHL			1.0	2.4	4.0	ns	
PLH	CLKAB	CLKOUT	2.6	5.2	7.7	20	
PHL			1.7	3.4	6.0	ns	
t _{PLH}	OEAB	B or CLKOUT	1.1	4.3	6.5		
PHL			1.0	2.0	4.3	ns	
RISE	Transition time, B out		2.3				
FALL	Transition time, B out	puts (80% to 20%)		1.6		ns	
RISE	Transition Time, A ou	tputs (10% to 90%)		2.3			
FALL	Transition Time, A ou	tputs (90% to 10%)		2.3		ns	
t _{PLH}	В	А	1.7	2.9	4.5		
PHL			1.7	3.2	5.8	ns	
PLH	LEBA	A	0.3	2.5	4.6	no	
PHL			0.4	2.5	4.6	ns	
PLH	CLKBA	A	0.5	2.6	4.6	no	
t _{PHL}			0.6	2.8	4.6	ns	
PLH	CLKOUT	CLKIN	1.2	2.4	5.3		
PHL			2.2	3.5	5.3	ns	
PZH, ^t PZL	OEBA	A or CLKIN	0.3	2.8	5.2		
PHZ, t _{PLZ}			0.3	2.5	5.2	ns	

Note 9: All typical values are at $V_{CC} = 3.3V$, and $T_A = 25^{\circ}C$.

AC Extended Electrical Characteristics

Over recommended ranges of supply voltage and operating free-air temperature $V_{REF} = 1.0V$ (unless otherwise noted). $C_L = 30$ pF for B Port and $C_L = 50$ pF for A Port.

Sumbal	From	То	Min	Тур	Max	Unit	
Symbol	(Input)	(Output)		(Note 10)			
t _{OSLH} (Note 11)	Α	В		0.3	1.0	ns	
t _{OSHL} (Note 11)				0.3	0.6		
t _{PVHL} (Note 12)(Note 13)	Α	В			2.5	ns	
t _{OSLH} (Note 11)	CLKAB	В		0.3	1.0	ns	
t _{OSHL} (Note 11)				0.3	0.6		
t _{PVHL} (Note 12)(Note 13)	CLKAB	В			2.5	ns	
t _{OSLH} (Note 11)	В	Α		0.3	0.5	ns	
t _{OSHL} (Note 11)				0.3	0.5		
t _{OST} (Note 11)	В	Α		0.5	1.2	ns	
t _{PV} (Note 12)	В	Α			2.5	ns	
t _{OSLH} (Note 11)	CLKBA	Α		0.3	0.5	ns	
t _{OSHL} (Note 11)				0.3	0.5		
t _{OST} (Note 11)	CLKBA	Α		0.5	1.2	ns	
t _{PV} (Note 12)	CLKBA	Α			2.5	ns	
t _{PVHL} (Note 11)(Note 12)	CLKAB	CLKOUT			2.8	ns	
t _{PDELLH} (Note 14)	В	CLKOUT	0		1.7	ns	
t _{PDELHL} (Note 14)			0		1.5		

Note 10: All typical values are at $V_{CC} = 3.3V$, and $T_A = 25$ °C.

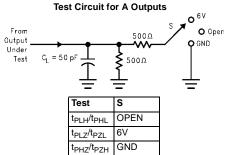
Note 11: t_{OSHL}/t_{OSLH} and t_{OST} - Output to output skew is defined as the absolute value of the difference between the actual propagation delay for all outputs within the same packaged device. The specifications are given for specific worst case V_{CC} and temperature and apply to any outputs switching in the same direction either HIGH-to-LOW (t_{OSHL}) or LOW-to-HIGH (t_{OSLH}) or in opposite directions both HL and LH (t_{OST}). This parameter is guaranteed by design and statistical process distribution. Actual skew values between the GTLP outputs could vary on the backplane due to the loading and impedance seen by the device.

Note 12: t_{PV} - Part to part skew is defined as the absolute value of the difference between the actual propagation delay for all outputs from device to device. The parameter is specified for a specific worst case V_{CC} and temperature. This parameter is guaranteed by design and statistical process distribution. Actual skew values between the GTLP outputs could vary on the backplane due to the loading and impedance seen by the device.

Note 13: Due to the open drain structure on GTLP outputs t_{OST} and $t_{PV(LH)}$ in the A-to-B direction are not specified. Skew on these paths is dependent on the V_{TT} and R_T values on the backplane.

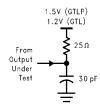
Note 14: tpDeLLH and tpDeLHL -B to CLKOUT propagation delay delta is defined as the difference between the CLKAB to CLKOUT propagation delay and the CLKAB to B propagation delays. This parameter is for a given device and is not meant to guarantee the delta between the CLKAB to CLKOUT propagation delays of one device and the CLKAB to B propagation delays of other devices. This parameter is guaranteed by design and statistical process distribution.

Test Circuits and Timing Waveforms



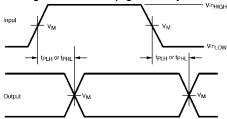
Note A: C_L includes probes and Jig capacitance

Test Circuit for B Outputs

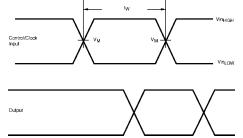


Note B: For B Port, C_L = 30 pF is used for worst case.

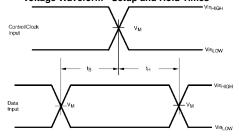
Voltage Waveform - Propagation Delay Times



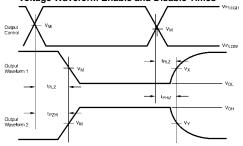
Voltage Waveform - Pulse Width



Voltage Waveform - Setup and Hold Times



Voltage Waveform Enable and Disable Times



Output Waveform 1 is for an output with internal conditions such that the output is LOW except when disabled by the control output. Output Waveform 2 is for an output with internal conditions such that the output is HIGH except when disabled by the control output.

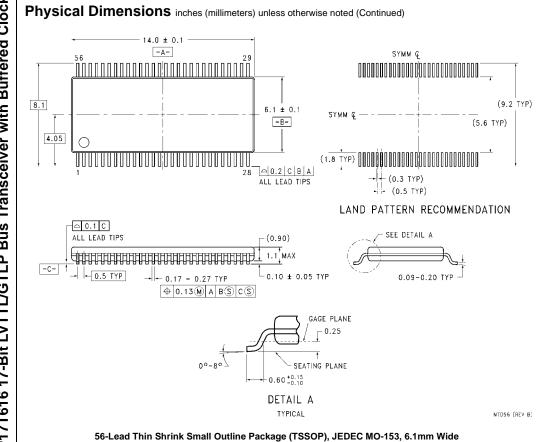
Input and Measure Conditions

	A or LVTTL Pins	B or GTLP Pins
V _{inHIGH}	V _{CC}	1.5
V_{inLOW}	0.0	0.0
V_{M}	V _{CC} /2	1.0
V _X	V _{OL} + 0.3V	N/A
V _Y	V _{OH} – 0.3V	N/A

All input pulses have the following characteristics: Frequency = 10MHz, $t_{RISE} = t_{FALL} = 2$ ns (10% to 90%), $Z_{O} = 50\Omega$ The outputs are measured one at a time with one transition per measurement.

Physical Dimensions inches (millimeters) unless otherwise noted 0.720 - 0.730 [18.30 - 18.54] - A -ĨÃOOODAAAAAAAAAAAAAAAAAAAAAAAÄÄ 0.398 - 0.417 [10.10 - 10.60] [\$\rightarrow\$ 0.010[0.25] C B \$ A\$ 0.291 - 0.299 [7.40 - 7.59] - B -0.005 - 0.009 [0.13 - 0.22] 0.020 ±0.003 TYP - 0.025 [0.635] TYP GAUGE PLANE 0.008 - 0.012 [0.21 - 0.30] TYP 0.010 [0.25] _0.020 - 0.040 [0.51 - 1.01] ⊕ 0.0031[0.08] W C A S B S DETAIL E TYP 45° x [0.015 - 0.025 [0.39 - 0.63] 0.096 - 0.108 [2.44 - 2.74] SEATING PLANE -SEE DETAIL E 0.004[0.10] 0.025 [0.635] TYP MS56A (REV E)

56-Lead Shrink Small Outline Package (SSOP), JEDEC MO-118, 0.300 Wide Package Number MS56A



Package Number MTD56

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